

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/002,915 KIM ET AL.	
		Examiner	Art Unit BRIAN P. YENKE 2614	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,754,371	06-2004	Kondo et al.	382/107
X	B	US-6,122,017	09-2000	Taubman, David S.	348/620
X	C	US-6,275,259	08-2001	Gowda et al.	348/229.1
X	D	US-5,434,627	07-1995	Weston, Martin	348/609
X	E	US-6,014,182	01-2000	Swartz, Peter D.	348/700
X	F	US-6,288,745	09-2001	Okuno et al.	348/448
X	G	US-6,788,823	09-2004	Allred et al.	382/260
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.